

**Notice of References Cited**

Application/Control No.

10/032,198

Applicant(s)/Patent Under  
Reexamination  
NOVOTNY ET AL.

Examiner

William C. Choi

Art Unit

2873

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0005976 A1	01-2002	Behin et al.	359/254
	B	US-2002/0171327 A1	11-2002	Miller et al.	310/309
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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 9/12/03